

Nemko Test Report:

10211699RUS3

Applicant:

Texas Instruments, Inc. 12500 TI Blvd. Dallas, TX 75243 USA

Equipment Under Test: (E.U.T.)

TRF7960AEVM

FCC ID.: Z64TRF7960AEVM

In Accordance With:

FCC Part 15, Subpart C, Paragraph 15.225 Operation within the band 13.110-14.010 MHz

Tested By:

TESTED BY:

Nemko USA Inc. 802 N. Kealy Lewisville, TX 75057

David Light, Senior Wireless Engineer

DATE: 28-Sept-2012

Date

110-

APPROVED BY:

Mike Cantwell, Engineering Manager

DATE: <u>28-Sep-2012</u> Date

Total Number of Pages: 17

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Summary Of Test Results Section 1.

Manufacturer: Texas Instruments, Inc.

Model No.: TRF7960AEVM

Serial No.: None

All measurements are traceable to national standards. General:

These tests were conducted on a sample of the equipment for the purpose of demonstrating compliance with FCC Part 15, Subpart C, Paragraph 15.225 for operation in the band 13.110-14.010 MHz. All tests were conducted using measurement procedure ANSI C63.4-2003.

\square	New Submission	\square	Production Unit
	Class II Permissive Change		Pre-Production Unit

Class II Permissive Change

THIS TEST REPORT RELATES ONLY TO THE ITEM(S) TESTED.

THE FOLLOWING DEVIATIONS FROM, ADDITIONS TO, OR EXCLUSIONS FROM THE TEST SPECIFICATIONS HAVE BEEN MADE. See "Summary of Test Data".



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Summary Of Test Data

NAME OF TEST	PARA. NO.	RESULT
Powerline Conducted Emissions	15.207	Complies
Field Strength	15.225(a)	Complies
Radiated Emissions	15.225(d)/15.209	Complies
Frequency Stability	15.225(e)	Complies

Footnotes:

Section 2. General Equipment Specification

Integral Antenna:	Yes	No
Supply Power:	3.3 Vdc via USB	
Operating Frequency(ies) of Sample:	13.56 MHz Fixed	
Frequency Range:	13.56 MHz Fixed	

Description of EUT

13.56 MHz RFID evaluation module. The unit was tested with both the Texas Instruments MSP-EXP430F5438 and the Stellaris DK-LM3S9B96 development boards.

Section 3. Powerline Conducted Emissions

NAME OF TEST: Powerline Conducted Emissions	PARA. NO.: 15.207
TESTED BY: Brian Boyea	DATE: 28 Sept. 2012

- Test Results:Complies. The worst case emission was 54.4 dBµV at
656 kHz. This is 1.6 dB below the quasi-peak specification
limit of 56.0 dBµV.
- Test Data:Refer to attached plots
- Equipment Used: 674-704-1258-1663-1988-1548
- Measurement Uncertainty: +/- 1.7 dB
- Temperature:22 °C
- **Relative Humidity:** 35 %

Test Data – Powerline Conducted Emissions

Frequency MHz	FCCB QP LIMIT	FCCB AVG LIMIT	AVG Meas	AVG Margin	QP Meas	QP Margin
0.328	60.9	50.9	42.6	-8.4	54.8	-6.1
0.343	60.5	50.5	40.7	-9.8	54.2	-6.3
0.356	60.1	50.1	39.2	-10.9	55.7	-4.5
0.369	59.7	49.7	40.8	-9.0	55.9	-3.9
0.376	59.5	49.5	42.5	-7.1	56.4	-3.1
0.379	59.5	49.5	42.8	-6.6	56.8	-2.6
0.383	59.3	49.3	43.1	-6.2	57.3	-2.1
0.395	59.0	49.0	42.2	-6.8	56.1	-2.9
0.656	56.0	46.0	41.3	-4.7	54.4	-1.6
0.685	56.0	46.0	39.5	-6.5	53.0	-3.0
0.83	56.0	46.0	36.0	-10.0	44.8	-11.2
0.91	56.0	46.0	38.5	-7.5	52.7	-3.3
0.94	56.0	46.0	38.8	-7.2	52.8	-3.2
1.21	56.0	46.0	39.4	-6.7	50.6	-5.4
1.92	56.0	46.0	38.8	-7.2	47.4	-8.6
2.1	56.0	46.0	38.3	-7.7	46.6	-9.4
2.1	56.0	46.0	38.2	-7.9	46.4	-9.6
2.1	56.0	46.0	38.2	-7.8	46.5	-9.5
2.11	56.0	46.0	38.1	-7.9	46.7	-9.3
2.12	56.0	46.0	35.9	-10.2	44.4	-11.6
2.13	56.0	46.0	38.1	-7.9	46.4	-9.6
2.15	56.0	46.0	37.2	-8.8	43.8	-12.3
2.16	56.0	46.0	37.9	-8.1	45.6	-10.4
2.29	56.0	46.0	37.9	-8.1	46.9	-9.1
2.31	56.0	46.0	37.3	-8.7	46.5	-9.5

Section 4. Field Strength

PARA. NO.: 15.225(a)

TESTED BY: David Light

DATE: 28 Sept. 2012

Complies.

Measurement Data:

Test Results:

Freq.	Meter	Antenna	Cable	Corrected	Spec.	Pol.	Comments:
	Reading	Factor	Loss	Reading	Limit		
(MHz)	(dBuV)	(dB)	(dB)	(dBuV/m)	(dBuV/m)		
							TI MSP-EXP430F5438
13.56	43.9	17.4	0.1	61.4	124	Loop	
							Stellaris DK-LM3S9B96
13.56	46.6	17.4	0.1	64.1	124	Loop	

Measurement Distance: 3 meters

Detector Bandwidth: 10 kHz/10 kHz

Detector Function: Peak

The specification limit was adjusted at 40 dB per decade from 30 meter limit.

Notes:

For handheld devices, the EUT was tested on three orthogonal axis'

The device was tested from 30 MHz to the tenth harmonic of the highest fundamental frequency per 15.33

The device was tested on three channels per 15.31(I).

Test Equipment Used: 1733-1767-1783

Measurement Uncertainty: +/-3.6 dB

Temperature:22 °C

Relative Humidity: <u>45</u> %

Nemko USA, Inc.

EQUIPMENT: TRF7960AEVM

Section 5. Radiated Emissions

NAME OF TEST: Radiated Emissions		PARA. NO.: 15.225(d)/15.209
TESTED BY: David Light		DATE: 28 Sept. 2012
Test Results:	Complies	
Test Equipment Used:	1767-1733-1763-1783-79	1
Measurement Uncertair		
Temperature:	_22_ °C	
Relative Humidity:	_45_ %	
Measurement Data:	Refer to data on following	page.

Test Data – Radiated Emissions

Texas Instruments MSP-EXP430F5438 Frequency FCC Peaks Peaks MHz **B** Limits H_Peaks Margin 32.4 40.0 32.2 -7.8 40.0 40.0 27.8 -12.2 103.8 43.5 20.8 -22.8 162.7 43.5 29.6 -13.9 199.9 43.5 -16.9 26.6 247.0 46.0 32.5 -13.5 332.9 46.0 33.7 -12.3 393.1 46.0 31.8 -14.3 420.3 46.0 36.8 -9.2 900.2 46.0 32.5 -13.5

Frequency	FCC	Peaks	Peaks
MHz	B Limits	V_Peaks	Margin
96.9	43.5	29.0	-14.5
162.7	43.5	26.6	-16.9
271.1	46.0	35.3	-10.8
420.3	46.0	36.4	-9.6
705.3	46.0	35.3	-10.7
732.5	46.0	36.8	-9.2
772.7	46.0	35.9	-10.1

Stellaris DK-LM3S9B96

Frequency	FCC	Peaks	Peaks
MHz	B Limits	H_Peaks	Margin
100.1	43.5	25.5	-18.0
119.8	43.5	27.6	-15.9
150.0	43.5	41.8	-1.8
168.3	43.5	32.8	-10.7
199.9	43.5	29.2	-14.3
327.2	46.0	35.1	-11.0
487.7	46.0	34.3	-11.7
515.0	46.0	34.0	-12.0
720.2	46.0	36.2	-9.8

Frequency	FCC	Peaks	Peaks
MHz	B Limits	V_Peaks	Margin
96.1	43.5	28.3	-15.2
150.2	43.5	34.7	-8.9
345.7	46.0	37.9	-8.2
596.7	46.0	34.8	-11.2
599.8	46.0	37.5	-8.5
624.0	46.0	36.1	-10.0

Section 6. Frequency Stability

NAME OF TEST: Frequency Stability		PARA. NO.: 15.225(e)	
TESTED BY: David Light		DATE: 28 September 2012	
Test Results:	Complies		
Test Equipment Used: 1	767-1733-1763		
Measurement Uncertainty:	<u>+/-3.6</u> dB		

Temperature:22°C

Relative Humidity: 45 %

Measurement Data:

Temp	Measured Frequency	Test	Freq. Error	Freq. Error	Limit	
(∘C)	(MHz)	Voltage	(Hz)	(%)	(±Hz)	Pass/Fail
20	13.560230	3.3	230	0.0017	1356	Р
20	13.560211	2.8	211	0.0016	1356	Р
20	13.560205	3.8	205	0.0015	1356	Р
-20	13.560199	3.3	199	0.0015	1356	Р
50	13.560241	3.3	241	0.0018	1356	Р

Section 7. Test Equipment List

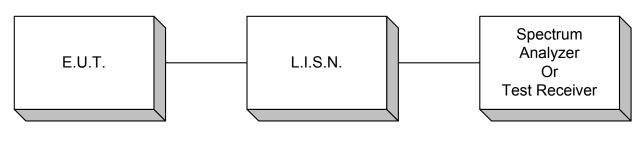
Asset Tag	Description	Manufacturer	Model	Serial #	Last Cal	Next Cal
674	Limiter	Hewlett Packard	11947A	3107A02200	01-Nov-2011	01-Nov-2012
704	Filter, High Pass, 5KHz	Solar Electronics	7930-5.0	933126	13-Feb-2012	13-Feb-2013
1258	LISN .15mhz- 30mhz	EMCO	3825/2	1305	31-Oct-2011	31-Oct-2012
1663	Spectrum Analyzer	Rohde & Schwartz	FSP3	100073	02-Sep-2011	02-Sep-2013
1733	Antenna, Active Loop	EMCO	6507	45939	08-May-2012	08-May-2013
1763	Antenna, Bilog	Schaffner	CBL 6111D	22926	21-Feb-2012	21-Feb-2013
1767	Receiver, EMI Test 20Hz - 26.5 GHz - 150 - +30 dBm LCD	Rohde & Schwartz	ESIB26	837491/0002	09-Dec-2011	09-Dec-2012
1783	Cable Assy, 3m Chamber	Nemko	Chamber		26-Sep-2012	26-Sep-2013
791	Watkins Johnson 30MHz to 1GHz Pre Amplifier	Nemko, USA	CRA69 321003 9605	119	19-Oct-2012	19-Oct-2013
1548	0.5m Cable Assy	Nemko USA	RG213		13-Feb-2012	13-Feb-2013

ANNEX A

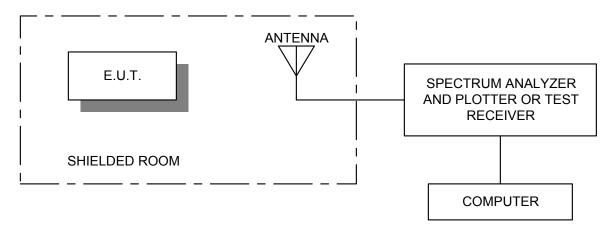
TEST DIAGRAMS

Conducted Emissions

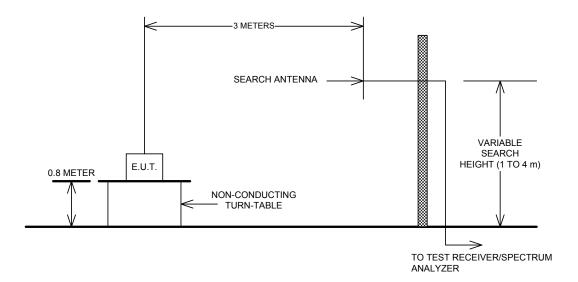
EQUIPMENT: TRF7960AEVM



Radiated Prescan



Test Site For Radiated Emissions



ANNEX B

TEST DETAILS

Nemko USA, Inc.

EQUIPMENT: TRF7960AEVM

NAME OF TEST: Powerline Conducted Emissions PARA. NO.: 15.207(a)

Minimum Standard: §15.207 Conducted limits.

(a) Except as shown in paragraphs (b) and (c) of this section, for an intentional radiator that is designed to be connected to the public utility (AC) power line, the radio frequency voltage that is conducted back onto the AC power line on any frequency or frequencies, within the band 150 kHz to 30 MHz, shall not exceed the limits in the following table, as measured using a 50 mH/50 ohms line impedance stabilization network (LISN). Compliance with the provisions of this paragraph shall be based on the measurement of the radio frequency voltage between each power line and ground at the power terminal. The lower limit applies at the boundary between the frequency ranges.

Frequency of Conducted Emission (MHz)	Limit (dBmV) Quasi-peak	Average
0.15-0.5	66 to 56*	56 to 46*
0.5-5	56	46
5-30	60	50
* Docroacos with the logari	thm of the frequency	

* Decreases with the logarithm of the frequency.

(b) The limit shown in paragraph (a) of this section shall not apply to carrier current systems operating as intentional radiators on frequencies below 30 MHz. In lieu thereof, these carrier current systems shall be subject to the following standards:

(1) For carrier current systems containing their fundamental emission within the frequency band 535-1705 kHz and intended to be received using a standard AM broadcast receiver: no limit on conducted emissions.

(2) For all other carrier current systems: 1000 mV within the frequency band 535-1705 kHz, as measured using a 50 mH/50 ohms LISN.

(3) Carrier current systems operating below 30 MHz are also subject to the radiated emission limits as provided in §15.205 and §§15.209, 15.221, 15.223, 15.225 or 15.227, as appropriate.

(c) Measurements to demonstrate compliance with the conducted limits are not required for devices which only employ battery power for operation and which do not operate from the AC power lines or contain provisions for operation while connected to the AC power lines. Devices that include, or make provision for, the use of battery chargers which permit operating while charging, AC adaptors or battery eliminators or that connect to the AC power lines indirectly, obtaining their power through another device which is connected to the AC power lines, shall be tested to demonstrate compliance with the conducted limits.

Nemko USA, Inc.

EQUIPMENT: TRF7960AEVM

NAME OF TEST: Operation in the band 13.110-14.010 MHz PARA. NO.: 15.225

(a) The field strength of any emissions within the band 13.553–13.567 MHz shall not exceed 15,848 microvolts/meter at 30 meters.

(b) Within the bands 13.410–13.553 MHz and 13.567–13.710 MHz, the field strength of any emissions shall not exceed 334 microvolts/meter at 30 meters.

(c) Within the bands 13.110–13.410 MHz and 13.710–14.010 MHz the field strength of any emissions shall not exceed 106 microvolts/meter at 30 meters.

(d) The field strength of any emissions appearing outside of the 13.110–14.010 MHz band shall not exceed the general radiated emission limits in §15.209.

(e) The frequency tolerance of the carrier signal shall be maintained within $\pm 0.01\%$ of the operating frequency over a temperature variation of -20 degrees to +50 degrees C at normal supply voltage, and for a variation in the primary supply voltage from 85% to 115% of the rated supply voltage at a temperature of 20 degrees C. For battery operated equipment, the equipment tests shall be performed using a new battery.

(f) In the case of radio frequency powered tags designed to operate with a device authorized under this section, the tag may be approved with the device or be considered as a separate device subject to its own authorization. Powered tags approved with a device under a single application shall be labeled with the same identification number as the device.